







MAX3232 SLLS4100 - JANUARY 2000 - REVISED JUNE 2021

# MAX3232 3-V to 5.5-V Multichannel RS-232 Line Driver and Receiver With ±15-kV ESD Protection

#### 1 Features

- RS-232 Bus-terminal esd protection exceeds ±15 kV using human-body model (HBM)
- Meets or exceeds the requirements of TIA/ EIA-232-F and ITU V.28 standards
- Operates with 3-V to 5.5-V V<sub>CC</sub> supply
- Operates up to 250 kbit/s
- Two drivers and two receivers
- Low supply current: 300 µA Typical
- External capacitors: 4 × 0.1 µF
- Accepts 5-V logic input with 3.3-V supply
- Alternative high-speed terminal-compatible devices (1 Mbit/s)
  - SN65C3232 (-40°C to 85°C)
  - SN75C3232 (0°C to 70°C)

### 2 Applications

- **Industrial PCs**
- Wired networking
- Data center and enterprise networking
- **Battery-powered systems**
- **PDAs**
- Notebooks
- Laptops
- Palmtop PCs
- Hand-held equipment

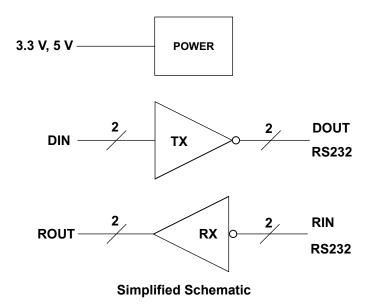
### 3 Description

The MAX3232 device consists of two line drivers. two line receivers, and a dual charge-pump circuit with ±15-kV ESD protection terminal to terminal (serial-port connection terminals, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. The devices operate at data signaling rates up to 250 kbit/s and a maximum of 30-V/µs driver output slew rate.

#### **Device Information**

PART NUMBER	PACKAGE <sup>(1)</sup>	BODY SIZE				
	SOIC (D) (16)	9.90 mm × 3.91 mm				
	SSOP (DB) (16)	6.20 mm × 5.30 mm				
MAX3232	SOIC (DW) (16)	10.30 mm × 7.50 mm				
	TSSOP (PW) (16)	5.00 mm × 4.40 mm				

For all available packages, see the orderable addendum at the end of the data sheet.





## **Table of Contents**

1 Features	1	8.2 Functional Block Diagram	9
2 Applications		8.3 Feature Description	
3 Description		8.4 Device Functional Modes	
4 Revision History		9 Application and Implementation	
5 Pin Configuration and Functions		9.1 Application Information	
6 Specifications		9.2 Standard Application	
6.1 Absolute Maximum Ratings		10 Power Supply Recommendations	
6.2 ESD Ratings		11 Layout	
6.3 Recommended Operating Conditions		11.1 Layout Guidelines	
6.4 Thermal Information		11.2 Layout Example	
6.5 Electrical Characteristics — Device	5	12 Device and Documentation Support	14
6.6 Electrical Characteristics — Driver	<u>5</u>	12.1 Receiving Notification of Documentation U	Jpdates14
6.7 Electrical Characteristics — Receiver	<mark>6</mark>	12.2 Support Resources	
6.8 Switching Characteristics	6	12.3 Trademarks	
6.9 Typical Characteristics		12.4 Electrostatic Discharge Caution	
7 Parameter Measurement Information		12.5 Glossary	
8 Detailed Description		13 Mechanical, Packaging, and Orderable	
8.1 Overview		Information	14
<b>4 Revision History</b> NOTE: Page numbers for previous revisions ma	ay differ f	rom page numbers in the current version.	
Changes from Revision N (June 2017) to Re	vision O	(June 2021)	Page
		g, and Data center and enterprise computing	
		d PW packages in the <i>Thermal Information</i> tab	
Changes from Revision M (April 2017) to Re	vision N	(June 2017)	Page
Changed the <i>Thermal Information</i> table			5
Changes from Revision L (March 2017) to Re	evision I	И (April 2017)	Page
Changed From: "±" To: "to" in the V <sub>CC</sub> colum			12
Changes from Revision K (January 2015) to	Revisio	n L (March 2017)	Page
<ul> <li>Changed pin 16 (V<sub>CC</sub>) in Typical Operating 0</li> </ul>	Circuit an	d Capacitor Values	
Changes from Revision J (January 2014) to	Revision	V / January 2045)	
		I K (January 2015)	Page
table, Typical Characteristics, Feature Desc	e Pin Fu		
implementation section. Power Supply Reco	ription se	nctions table, ESD Ratings table, Thermal Infoction, Device Functional Modes, Application ar	rmation
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# **5 Pin Configuration and Functions**

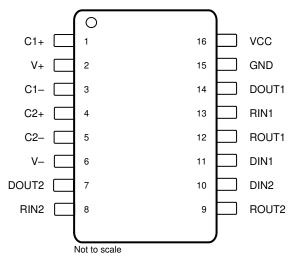


Figure 5-1. D, DB, DW, or PW Package, 16-Pin SOIC, SSOP, or TSSOP, Top View

**Table 5-1. Pin Functions** 

PIN		TYPE	DESCRIPTION
NAME	NO.	ITPE	DESCRIPTION
C1+	1	_	Positive lead of C1 capacitor
V+	2	0	Positive charge pump output for storage capacitor only
C1-	3	_	Negative lead of C1 capacitor
C2+	4	_	Positive lead of C2 capacitor
C2-	5	_	Negative lead of C2 capacitor
V-	6	0	Negative charge pump output for storage capacitor only
DOUT2	7	0	RS232 line data output (to remote RS232 system)
DOUT1	14	0	RS232 line data output (to remote RS232 system)
RIN2	8	I	RS232 line data input (from remote RS232 system)
RIN1	13	I	RS232 line data input (from remote RS232 system)
ROUT2	9	0	Logic data output (to UART)
ROUT1	12	0	Logic data output (to UART)
DIN2	10	I	Logic data input (from UART)
DIN1	11	I	Logic data input (from UART)
GND	15	_	Ground
V <sub>CC</sub>	16	_	Supply Voltage, Connect to external 3 V to 5.5 V power supply



## **6 Specifications**

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range <sup>(2)</sup>		-0.3	6	V
V+	Positive output supply voltage range <sup>(2)</sup>		-0.3	7	V
V-	Negative output supply voltage range <sup>(2)</sup>		-7	0.3	V
V+ – V–	Supply voltage difference <sup>(2)</sup>			13	V
V	Input voltage range	Drivers	-0.3	6	V
V <sub>I</sub>	input voitage range	Receivers	-25	25	V
V	Output voltage range	Drivers	-13.2	13.2	V
Vo	Output voltage range	Receivers	-0.3	V <sub>CC</sub> + 0.3	V
TJ	Operating virtual junction temperature			150	°C
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

(2) All voltages are with respect to network GND.

## 6.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 RIN , DOUT, and GND pins <sup>(1)</sup>	15000	
V <sub>(ESD)</sub>	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 All other pins <sup>(1)</sup>	3000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup>	1000	

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## **6.3 Recommended Operating Conditions**

(see Typical Operating Circuit and Capacitor Values)(1)

		·		MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage		V <sub>CC</sub> = 3.3 V	3	3.3	3.6	V
V CC	Supply voltage		V <sub>CC</sub> = 5 V	4.5	5	5.5	V
V	V Daissan himb lassal immediately	DIN	V <sub>CC</sub> = 3.3 V	2			V
V <sub>IH</sub>	Driver high-level input voltage	Tilgh-level input voltage	V <sub>CC</sub> = 5 V	2.4			V
V <sub>IL</sub>	Driver low-level input voltage	DIN				0.8	V
VI	Driver input voltage	DIN		0		5.5	V
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	Receiver input voltage	RIN		-25		25	V
т	Operating free air temperature		MAX3232C	0		70	°C
T <sub>A</sub>	Operating nee-ail temperature	perating free-air temperature	MAX3232I	-40		85	C

(1) Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

Product Folder Links: MAX3232

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

#### 6.4 Thermal Information

			MAX3232				
	THERMAL METRIC <sup>(1)</sup>	SOIC (D)	SSOP (DB)	SOIC (DW)	TSSOP (PW)	UNIT	
			16 PI	NS			
$R_{\theta JA}$	Junction-to-ambient thermal resistance	85.9	103.1	66.6	108.2	°C/W	
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	43.1	49.2	32.4	39.0	°C/W	
$R_{\theta JB}$	Junction-to-board thermal resistance	44.5	54.8	31.9	54.4	°C/W	
ΨЈТ	Junction-to-top characterization parameter	10.1	12	8.4	3.3	°C/W	
ΨЈВ	Junction-to-board characterization parameter	44.1	54.1	31.5	53.8	°C/W	
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	n/a	n/a	n/a	n/a	°C/W	

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

#### 6.5 Electrical Characteristics — Device

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(2)</sup> (see Typical **Operating Circuit and Capacitor Values)** 

	PARAMETER	TEST CONDITIONS		MIN	TYP <sup>(1)</sup>	MAX	UNIT
I <sub>CC</sub>	Supply current	No load,	V <sub>CC</sub> = 3.3 V to 5 V		0.3	1	mA

- All typical values are at V $_{CC}$  = 3.3 V or V $_{CC}$  = 5 V, and T $_{A}$  = 25°C. Test conditions are C1–C4 = 0.1  $\mu$ F at V $_{CC}$  = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V $_{CC}$  = 5 V  $\pm$  0.5 V.

### 6.6 Electrical Characteristics — Driver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(3) (see Typical **Operating Circuit and Capacitor Values)** 

	PARAMETER	TEST CONDITIO	NS N	/IN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	$D_{OUT}$ at $R_L = 3 \text{ k}\Omega$ to GND, $D_{IN}$	= GND	5	5.4		V
V <sub>OL</sub>	Low-level output voltage	$D_{OUT}$ at $R_L = 3 \text{ k}\Omega$ to GND, $D_{IN}$	= V <sub>CC</sub>	-5	-5.4		V
I <sub>IH</sub>	High-level input current	V <sub>I</sub> = V <sub>CC</sub>			±0.01	±1	μA
I <sub>IL</sub>	Low-level input current	V <sub>I</sub> at GND			±0.01	±1	μA
I <sub>OS</sub> (2)	Short-circuit output current	V <sub>CC</sub> = 3.6 V V <sub>O</sub>	= 0 V		±35	±60	mA
'os (=/	Short-circuit output current	V <sub>CC</sub> = 5.5 V V <sub>O</sub>	= 0 V		133	±00	ША
r <sub>O</sub>	Output resistance	$V_{CC}$ , V+, and V- = 0 V $V_{O}$	= ±2 V 3	300	10M		Ω

- All typical values are at  $V_{CC}$  = 3.3 V or  $V_{CC}$  = 5 V, and  $T_A$  = 25°C.
- Short-circuit durations should be controlled to prevent exceeding the device absolute power dissipation ratings, and not more than one output should be shorted at a time.
- Test conditions are C1–C4 = 0.1  $\mu$ F at  $V_{CC}$  = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at  $V_{CC}$  = 5 V  $\pm$  0.5



#### 6.7 Electrical Characteristics — Receiver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(2) (see Typical **Operating Circuit and Capacitor Values)** 

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	I <sub>OH</sub> = -1 mA	V <sub>CC</sub> - 0.6	V <sub>CC</sub> - 0.1		V
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 1.6 mA			0.4	V
V Decitive gains input threehold valtage	V <sub>CC</sub> = 3.3 V		1.5	2.4	V	
VIT+	V <sub>IT+</sub> Positive-going input threshold voltage	V <sub>CC</sub> = 5 V		1.8	2.4	V
.,	Negative-going input threshold voltage	V <sub>CC</sub> = 3.3 V	0.6	1.2		V
V <sub>IT</sub>	Negative-going input theshold voltage	V <sub>CC</sub> = 5 V	0.8	1.5		V
V <sub>hys</sub>	Input hysteresis (V <sub>IT+</sub> – V <sub>IT-</sub> )			0.3		V
r <sub>l</sub>	Input resistance	V <sub>I</sub> = ±3 V to ±25 V	3	5	7	kΩ

## 6.8 Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(3) (see Typical **Operating Circuit and Capacitor Values)** 

	PARAMETER	TEST C	ONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
	Maximum data rate	$R_L = 3 k\Omega$ ,	C <sub>L</sub> = 1000 pF	150	250		kbit/s
	Maximum data rate	One D <sub>OUT</sub> switching,	See Figure 7-1	150	250		KDII/S
	Driver Pulse skew <sup>(2)</sup>	$R_1 = 3 k\Omega$ to $7 k\Omega$ ,	C <sub>L</sub> = 150 to 2500 pF		300		no
t <sub>sk(p)</sub>	Dilvei Fuise skew	KL - 3 K22 to 7 K22,	See Figure 7-2		300		ns
SR(tr)	Slew rate, transition region	$R_L = 3 k\Omega$ to $7 k\Omega$ ,	C <sub>L</sub> = 150 to 1000 pF	6		30	V/µs
SK(ii)	(see Figure 7-1)	V <sub>CC</sub> = 5 V	C <sub>L</sub> = 150 to 2500 pF	4	-	30	v/µs
t <sub>PLH®)</sub>	Propagation delay time, low- to high-level output	C = 150 pE			300		
t <sub>PHL®)</sub>	Propagation delay time, high- to low-level output	- 150 pF	C <sub>L</sub> = 150 pF		300		ns
t <sub>sk(p)</sub>	Receiver Pulse skew <sup>(3)</sup>				300		

All typical values are at  $V_{CC}$  = 3.3 V or  $V_{CC}$  = 5 V, and  $T_A$  = 25°C.

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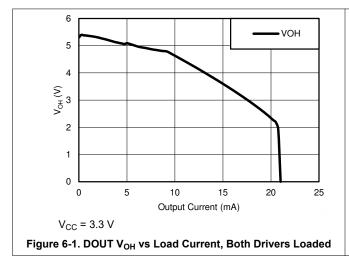
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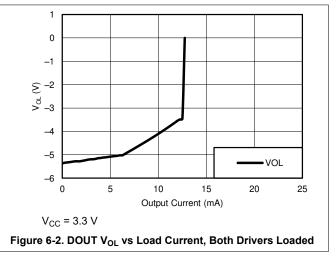
All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25 °C. Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V  $\pm$  0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

<sup>(2)</sup> 

Pulse skew is defined as  $|t_{PLH} - t_{PHL}|$  of each channel of the same device. Test conditions are C1–C4 = 0.1  $\mu$ F at  $V_{CC}$  = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at  $V_{CC}$  = 5 V ± 0.5 V. (3)

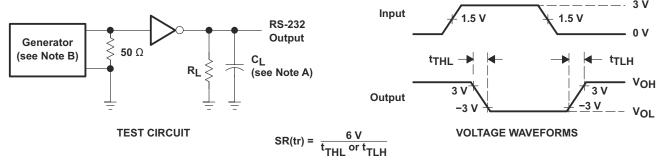
# **6.9 Typical Characteristics**





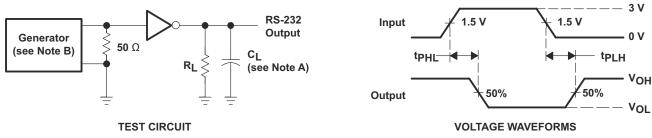


### 7 Parameter Measurement Information



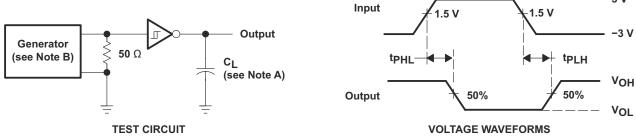
- A. C<sub>L</sub> includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: PRR = 250 kbit/s,  $Z_O = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns.  $t_f \le 10$  ns.

Figure 7-1. Driver Slew Rate



- A. C<sub>L</sub> includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: PRR = 250 kbit/s,  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

Figure 7-2. Driver Pulse Skew



- A. C<sub>L</sub> includes probe and jig capacitance.
- B. The pulse generator has the following characteristics:  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns.  $t_f \le 10$  ns.

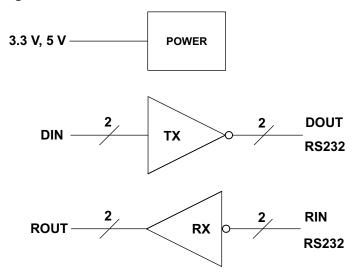
Figure 7-3. Receiver Propagation Delay Times

### **8 Detailed Description**

### 8.1 Overview

The MAX3232 device consists of two line drivers, two line receivers, and a dual charge-pump circuit with ±15-kV ESD protection terminal to terminal (serial-port connection terminals, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. The device operates at data signaling rates up to 250 kbit/s and a maximum of 30-V/µs driver output slew rate. Outputs are protected against shorts to ground.

### 8.2 Functional Block Diagram



### 8.3 Feature Description

#### 8.3.1 Power

The power block increases, inverts, and regulates voltage at V+ and V- pins using a charge pump that requires four external capacitors.

#### 8.3.2 RS232 Driver

Two drivers interface standard logic level to RS232 levels. Both DIN inputs must be valid high or low.

#### 8.3.3 RS232 Receiver

Two receivers interface RS232 levels to standard logic levels. An open input will result in a high output on ROUT. Each RIN input includes an internal standard RS232 load.



#### **8.4 Device Functional Modes**

Table 8-1. Each Driver<sup>(1)</sup>

INPUT DIN	OUTPUT DOUT
L	Н
Н	L

(1) H = high level, L = low level

Table 8-2. Each Receiver<sup>(1)</sup>

INPUT RIN	OUTPUT ROUT
L	Н
Н	L
Open	н

(1) H = high level, L = low level, Open = input disconnected or connected driver off

## 8.4.1 V<sub>CC</sub> powered by 3 V to 5.5 V

The device will be in normal operation.

## 8.4.2 $V_{CC}$ unpowered, $V_{CC} = 0 V$

When MAX3232 is unpowered, it can be safely connected to an active remote RS232 device.

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## 9 Application and Implementation

#### **Note**

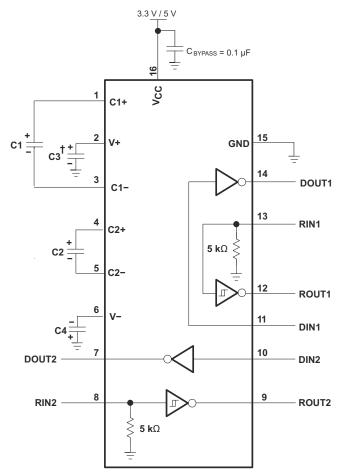
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 9.1 Application Information

For proper operation, add capacitors as shown in Typical Operating Circuit and Capacitor Values.

### 9.2 Standard Application

ROUT and DIN connect to UART or general purpose logic lines. RIN and DOUT lines connect to a RS232 connector or cable.



- $\dagger$  C3 can be connected to  $V_{CC}$  or GND.
- A. Resistor values shown are nominal.
- B. Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

Figure 9-1. Typical Operating Circuit and Capacitor Values



### 9.2.1 Design Requirements

- Recommended  $V_{CC}$  is 3.3 V or 5 V. 3 V to 5.5 V is also possible
- · Maximum recommended bit rate is 250 kbit/s.

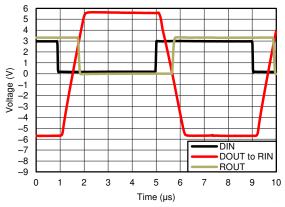
Table 9-1. V<sub>CC</sub> vs Capacitor Values

V <sub>CC</sub>	C1	C2, C3, C4			
3.3 V ± 0.3 V	0.1 μF	0.1 μF			
5 V ± 0.5 V	0.047 μF	0.33 μF			
3 V to 5.5 V	0.1 μF	0.47 μF			

### 9.2.2 Detailed Design Procedure

- All DIN, FORCEOFF and FORCEON inputs must be connected to valid low or high logic levels.
- · Select capacitor values based on VCC level for best performance.

#### 9.2.3 Application Curves



 $V_{CC} = 3.3 \text{ V}$ 

Figure 9-2. 250 kbit/s Driver to Receiver Loopback Timing Waveform

## 10 Power Supply Recommendations

 $V_{CC}$  should be between 3 V and 5.5 V. Charge pump capacitors should be chosen using table in Typical Operating Circuit and Capacitor Values.

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# 11 Layout

## 11.1 Layout Guidelines

Keep the external capacitor traces short. This is more important on C1 and C2 nodes that have the fastest rise and fall times.

## 11.2 Layout Example

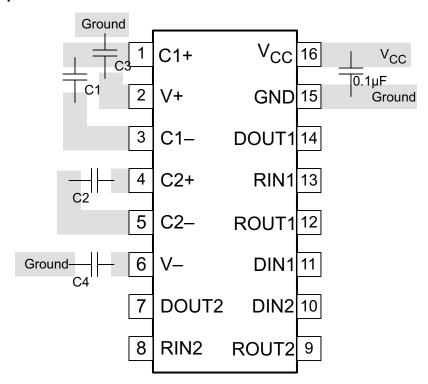


Figure 11-1. Layout Diagram



## 12 Device and Documentation Support

### 12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 12.2 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 12.3 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

### 12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 12.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser based versions of this data sheet, refer to the left hand navigation.

Product Folder Links: MAX3232

21-Feb-2024 www.ti.com

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
MAX3232CDBR	ACTIVE	SSOP	DB	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C	Samples
MAX3232CDR	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MAX3232C	Samples
MAX3232CDW	LIFEBUY	SOIC	DW	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MAX3232C	
MAX3232CDWG4	NRND	SOIC	DW	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MAX3232C	
MAX3232CDWR	LIFEBUY	SOIC	DW	16	2000	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	0 to 70	MAX3232C	
MAX3232CPWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C	Samples
MAX3232CPWRE4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C	Samples
MAX3232CPWRG4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C	Samples
MAX3232IDBR	ACTIVE	SSOP	DB	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I	Samples
MAX3232IDBRE4	ACTIVE	SSOP	DB	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I	Samples
MAX3232IDW	LIFEBUY	SOIC	DW	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MAX3232I	
MAX3232IDWR	ACTIVE	SOIC	DW	16	2000	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	MAX3232I	Samples
MAX3232IDWRE4	NRND	SOIC	DW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MAX3232I	
MAX3232IDWRG4	LIFEBUY	SOIC	DW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MAX3232I	
MAX3232IPWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I	Samples
MAX3232IPWRE4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I	Samples
MAX3232IPWRG4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

## PACKAGE OPTION ADDENDUM

www.ti.com 21-Feb-2024

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF MAX3232:

Enhanced Product : MAX3232-EP

NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications



www.ti.com 11-Dec-2023

### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MAX3232CDBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
MAX3232CDR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
MAX3232CDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
MAX3232CPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232CPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232CPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232IDBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
MAX3232IDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
MAX3232IDWRG4	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
MAX3232IPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232IPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232IPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232IPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



www.ti.com 11-Dec-2023



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
MAX3232CDBR	SSOP	DB	16	2000	356.0	356.0	35.0
MAX3232CDR	SOIC	D	16	2500	356.0	356.0	35.0
MAX3232CDWR	SOIC	DW	16	2000	350.0	350.0	43.0
MAX3232CPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232CPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232CPWRG4	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232IDBR	SSOP	DB	16	2000	356.0	356.0	35.0
MAX3232IDWR	SOIC	DW	16	2000	350.0	350.0	43.0
MAX3232IDWRG4	SOIC	DW	16	2000	350.0	350.0	43.0
MAX3232IPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232IPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232IPWRG4	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232IPWRG4	TSSOP	PW	16	2000	356.0	356.0	35.0

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 11-Dec-2023

### **TUBE**



#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
MAX3232CDW	DW	SOIC	16	40	506.98	12.7	4826	6.6
MAX3232CDWG4	DW	SOIC	16	40	506.98	12.7	4826	6.6
MAX3232IDW	DW	SOIC	16	40	506.98	12.7	4826	6.6

7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





SOIC



#### NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.



SOIC



#### NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



#### NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# D (R-PDS0-G16)

## PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.







#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-150.





NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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